Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/672,560	HATFIELD, ERIC	
Examiner	Art Unit	
Mark Eashoo, Ph.D.	1732	

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INT	INTERFERENCE SEARCHED		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT)- see search history printout	12/5/2005	ME		